High Capacitance Tantalum Solid Electrolytic Chip Capacitors Undertab Series





FEATURES

- · Large Case Size for Maximum Capacitance
- 3x Reflow 260°C Compatible
- 100% Surge Current Tested
- · Low Profile Solution
- **Consumer Applications** (e.g. PCMCIA/USB Wireless Express Cards etc.)
- CV Range: 1000-3300µF / 4-10V
- · 2 Case Sizes Available

APPLICATIONS

- · Data Transfer Modems
- · SSD Backup Circuits





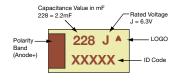
CASE DIMENSIONS:

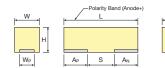
millimeters (inches)

Code	EIA Code	EIA Metric	L±0.20 (0.008)	W+0.20 (0.008) -0.10 (0.004)	H max.	W _P ±0.10 (0.004)	W _N ±0.10 (0.004)	A _P ±0.10 (0.004)	A _N ±0.10 (0.004)	S Min.
4	2924	7361-20	7.30 (0.287)	6.10 (0.240)	2.00 (0.079)	4.75 (0.187)	4.75 (0.187)	2.00 (0.079)	3.20 (0.126)	2.10 (0.083)
6	5831	14878-20	14.80 (0.583)	7.80 (0.307)	2.00 (0.079)	5.50 (0.217)	5.50 (0.217)	2.45 (0.096)	2.45 (0.096)	9.90 (0.390)

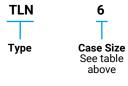
MARKING

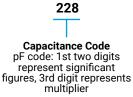
4,6 CASE



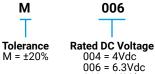


HOW TO ORDER









010 = 10 Vdc







ESR in mΩ

TECHNICAL SPECIFICATIONS

Technical Data:			All technical data relate to an ambient temperature of +25°C							
Capacitance Range:	1000 μF to 3300 μF									
Capacitance Tolerance:			±20%							
Leakage Current DCL:		0.01CV								
Rated Voltage (V _R)	-55°C ≤ +40°C:	4	6.3	10						
Category Voltage (V _c) at 85°C:		2	3.2	5						
Category Voltage (V _c)	at 125°C:	0.8	1.3	2						
Temperature Range:		-55°C to	+125°C v	vith cate	gory voltage					
Reliability:		0.2% per 1000 hours at 85°C, 0.5xV $_{\text{R}}$ with 0.1 Ω /V series impedance with 60% confidence level								





CAPACITANCE AND RATED VOLTAGE RANGE (LETTER DENOTES CASE SIZE)

Capac	citance	Voltage Rating DC (VR) to 85°C							
μF	Code	4V (G)	6.3V (J)	10V (A)					
680	687								
1000	108			4(100)/6(55)					
1500	158		4(100)	6(55)					
2200	228		6(55)						
3300	338	6(55)							

Released ratings (ESR ratings in mOhms in parentheses)

Note: Voltage ratings are minimum values. KYOCERA AVX reserves the right to supply higher voltage ratings in the same case size, to the same reliability standards.

RATINGS & PART NUMBER REFERENCE

	Case	Capacitance	Rated Voltage (V)	Rated Temperature (°C)	Category Voltage (V)	Category Temperature (°C)	DCL Max. (µA)	ESR Max. @ 100kHz (mΩ)	100kHz RMS Current (mA)			
Part Number	Size	(μF)							25°C	85°C	125°C	MSL
4 Volt @ 40°C												
TLN6338M004#0055	6	3300	4	40	0.8	125	132	55	2045	1840	818	3
	6.3 Volt @ 40°C											
TLN4158M006#0100	4	1500	6.3	40	1.3	125	90	100	1285	1156	514	3
TLN6228M006#0055	6	2200	6.3	40	1.3	125	132	55	2045	1840	818	3
	10 Volt @ 40°C											
TLN4108M010#0100	4	1000	10	40	2	125	100	100	1285	1156	514	3
TLN6108M010#0055	6	1000	10	40	2	125	100	55	2045	1840	818	3
TLN6158M010#0055	6	1500	10	40	2	125	150	55	2045	1840	818	3

Moisture Sensitivity Level (MSL) is defined according to J-STD-020.

All technical data relates to an ambient temperature of +25°C. Capacitance and DF are measured at 120Hz, 0.5V RMS with a maximum DC bias of 2.2 volts.

DCL is measured at rated voltage after 5 minutes.

ESR allowed to move up to 1.25 times catalogue limit post mounting

DCL allowed to move up to 2.00 times catalogue limit post mounting

For typical weight and composition, see page 253.

NOTE: KYOCERA AVX reserves the right to supply higher voltage ratings or tighter tolerance part in the same case size, to the same reliability standards.

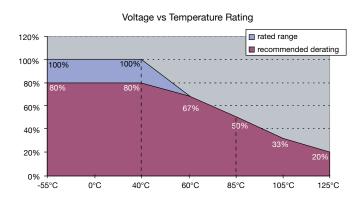
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QUALIFICATION TABLE

TEST	TLN PulseCap™ series (Temperature range -55°C to +125°C)											
1591		Condition	Characteristics									
	Apply rated voltage	ge (Ur) at 40°C and	/ or category	Visual examination	amination no visible damage							
Endurance		5°C for 2000 hours	DCL	2 x initia	2 x initial limit							
Eliquialice		.1Ω/V. Stabilize at ro	ΔC/C	within +	within +5/-30% of initial value							
	for 1-2 hours befo	ore measuring.	ESR	1.25 x ir	1.25 x initial limit							
	Store at 65°C and	d 90-95% relative hu	ımidity for 500	Visual examination	no visib	no visible damage						
Llumaiditus		plied voltage. Stabi	,	DCL	2 x initia	2 x initial limit						
Humidity		humidity for 1-2 ho	ΔC/C	within ±	within ±10% of initial value							
	measuring.		ESR	1.25 x ir	1.25 x initial limit							
	Step 1	Temperature°C +20	Duration(min) 15	_	+20°C	-55°C	+20°C	+85°C	+125°C	+20°C		
Temperature	2	-55	15	DCL	2 x IL*	n/a	2 x IL*	20 x IL*	25 x IL*	2 x IL ⁷		
Stability	3	+20 +85	15 15	ΔC/C	n/a	+5/-20%	±10%	+20/-0%	±25/-0%	+10%		
Otability	5	+125	15									
	6	+20	15	ESR	1.25xIL*			1.25 x IL*	1.25 X IL*	1.25XIL		
		voltage (Ur) at 40°C		Visual examination		no visible damage						
Surge		(30 sec charge, 5 r	DCL		2 x initial limit							
Voltage	discharge) throug	gh a charge / discha	ΔC/C		within ±5% of initial value							
	οι τουοίλ			ESR	1.25 x ir	nitial limit			25 x IL* 2 x IL* 5 +25/-0% ±10%			
				Visual examination	no visible damage							
Mechanical				DCL	initial lir	initial limit						
Shock	MIL-STD-202, Me	thod 213, Condition	ΔC/C	within ±	within ±5% of initial value							
SHOCK				DF	initial lir	initial limit						
				ESR	initial lir	initial limit						
				Visual examination	no visib	no visible damage						
	MIL-STD-202, Method 204, Condition D			DCL	initial lir	initial limit						
Vibration				ΔC/C	within ±	within ±5% of initial value						
				DF	initial lir	initial limit						
			ESR	initial lir	initial limit							

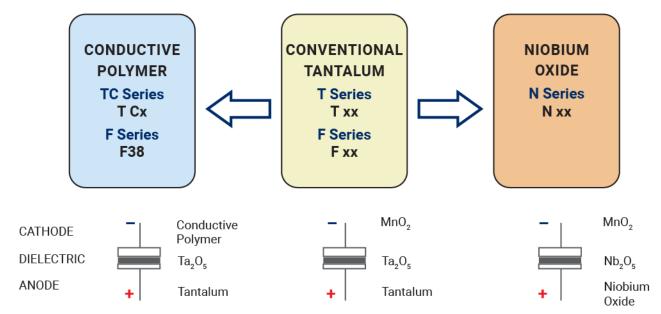
^{*}Initial Limit



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SOLID ELECTROLYTIC CAPACITOR ROADMAP



FIVE CAPACITOR CONSTRUCTION STYLES



SERIES LINE UP: CONVENTIONAL SMD MnO,

